Ballistic charge transport in chiral-symmetric few-layer graphene

W.-R. Hannes¹ and M. Titov^{1,2}

School of Engineering & Physical Sciences, Heriot-Watt University, Edinburgh EH14 4AS, UK DFG Center for Functional Nanostructures, Universität Karlsruhe, 76128 Karlsruhe, Germany

PACS 73.23.-b - Electronic transport in mesoscopic systems

Abstract. - A transfer matrix approach to study ballistic charge transport in few-layer graphene with chiral-symmetric stacking configurations is developed. We demonstrate that the chiral symmetry justifies a non-Abelian gauge transformation at the spectral degeneracy point (zero energy). This transformation proves the equivalence of zero-energy transport properties of the multilayer to those of the system of uncoupled monolayers. Similar transformation can be applied in order to gauge away an arbitrary magnetic field, weak strain, and hopping disorder in the bulk of the sample. Finally, we calculate the full-counting statistics at arbitrary energy for different stacking configurations. The predicted gate-voltage dependence of conductance and noise can be measured in clean multilayer samples with generic metallic leads.

1 School of Engineering & Physical Sciences, Heriot-Watt
2 DFG Center for Functional Nanostructures, Universität

PACS 73.23.-b - Electronic transport in mesoscopic PACS 73.23.Ad - Ballistic transport PACS 73.50.Td - Noise processes and phenomena

Abstract. - A transfer matrix approach to study bal with chiral-symmetric stacking configurations is devel metry justifies a non-Abelian gauge transformation at This transformation proves the equivalence of zero-er to those of the system of uncoupled monolayers. Sim to gauge away an arbitrary magnetic field, weak stra sample. Finally, we calculate the full-counting statistic configurations. The predicted gate-voltage dependence in clean multilayer samples with generic metallic lead tructure [2, 3]. Graphene and topological metals realised in BiSb compounds [4] are very recent examples where exotic band-structure properties are responsible for unusual quantum effects in the charge transport. The well-known one is the integer quantum Hall effect that takes on remarkably distinct forms in mono- and bi-layer graphene one is the integer quantum Hall effect that takes on remarkably distinct forms in mono- and bi-layer graphene [5-7]. The continuing development of device fabrication technology promises interesting applications of these ef-

fects in microelectronic, information.

At the same time there is a growing interest in new functionalities of few-layer graphene that is inspired by proposals to control valley polarisation [8, 9], band a metic exchange [11] with the help of a vidence supporting these theoretical proposals is currently building up [12,13]. Few-layer graphene is also a prime candidate for the observation of excitonic condensation caused by an attractive interlayer Coulomb interaction [14, 15].

In this letter we develop a unified approach to transport properties of chiral-symmetric multilayer setups shown in fig. 1. Our main result is the universality of the fullcounting statistics for the charge transport at the spectral degeneracy point ($\varepsilon = 0$). We demonstrate that this universality is the consequence of the chiral symmetry of

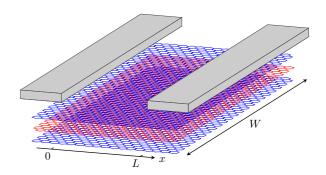


Fig. 1: Schematic view of a rectangular trilayer graphene sample contacted by metallic leads.

the tight-binding model of graphene multilayer. Therefore, it extends to arbitrary perturbations of the model, which preserve the chiral symmetry. Such perturbations include: weak crystal strains, arbitrary magnetic field, and interlayer hopping disorder.

The universal charge transport is provided by the evanescent modes that originate at the metal-graphene boundaries. We find that the universal two-terminal conductivity of the setup is given by $\sigma = 4Me^2/\pi h$, where M is the number of layers, e is the electron charge, and h is the Planck constant. The Fano factor at zero energy takes on the universal value F = 1/3. These results are insensitive to magnetic field, weak strain, and hopping disorder, which can be gauged away from the full-counting

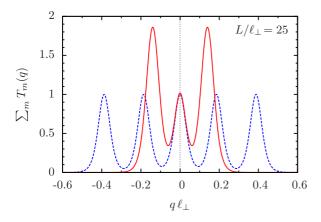


Fig. 2: The sum of transmission probabilities, $\sum_{m=1}^{M} T_m(q)$, at $\varepsilon = 0$ as a function of the transversal momentum q in the case of few layer graphene (M = 5) with Bernal (solid line) and rhombohedral (dashed line) stacking and vanishing magnetic field.

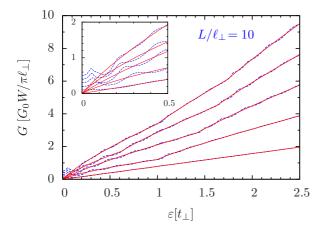


Fig. 3: Quantum-mechanical (dashed lines) and averaged conductance of AB-stacked few-layer graphene as a function of the Fermi-energy. The layer number is one through five from bottom to top. The inset is a zoom into the low-energy region.

statistics by means of a non-Abelian gauge transformation. Individual transmission eigenvalues are, however, less universal and strongly depend on the stacking configuration (see fig. 2).

In the second part of the letter we adopt the scattering approach to calculate the full-counting statistics of the charge transport away from the degeneracy point for $\varepsilon\gg\hbar v/L$, where L is the distance between the metallic leads and v is the Fermi velocity. This transport regime is dominated by the propagating modes that give rise to the sample-dependent Fabri-Perot oscillations in the conductance and noise of the ballistic setup. The gate-voltage dependence of these quantities is further analyzed by averaging over the Fabri-Perot oscillations. Our results for regular stacks are presented in figs. 3-5. For any multilayer above the highest band threshold we find the averaged conductance $G=Me^2W|\varepsilon|/h$ and seemingly universal value of the Fano factor, F=1/8.

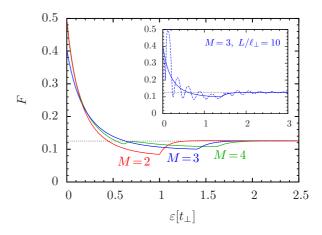


Fig. 4: Averaged Fano factor in transport through AB-stacked few-layer graphene. The horizontal line corresponds to F=1/8. The inset shows a comparison with the exact result (dashed curve) found from eqs. (9,7,8).

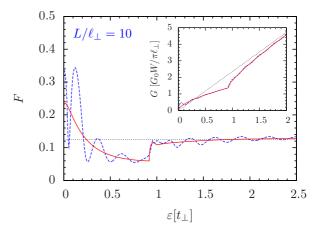


Fig. 5: Exact (dashed line) and averaged (solid line) Fano factor for ABC-stacked trilayer graphene. The inset shows the transmission spectrum.

Model. — The chiral symmetry is preserved in the nearest-neighbour tight-binding model of few-layer graphene for the regular stacking types, Bernal $(AB\cdots)$ and rhombohedral $(ABC\cdots)$, and for all irregular ones excluding sequences of the type AA.

For these models the Fermi surface becomes point-like at the spectrum degeneracy point ($\varepsilon=0$). At this energy no propagating states exist, hence the conductivity of the idealised material is expected to vanish. This is, however, not true in the setup of a finite size shown in fig. 1 due to the presence of zero-energy evanescent modes, which contribute to the transport in a peculiar way [16–22]. The theory predicts the conductance of a ballistic monolayer setup $G=\sigma W/L$, where the two-terminal conductivity, σ , approaches the universal value $4e^2/\pi h$ at zero energy, while the Fano takes on the value F=1/3 as in a diffusive system. Such pseudo-diffusive transport regime has been indeed observed in experiments [23, 24] with submicron monolayer flakes.

Here we extend and generalize these results for few-layer chiral-symmetric graphene. The model Hamiltonian is given by the sum of four terms $H=H_0+H_A+H_S+H_\perp$, where H_0 describes the system of M uncoupled monolayers, H_A and H_S account for magnetic field and weak internal strain, correspondingly, and H_\perp takes into account the coupling between the layers.

In the effective mass approximation the Hamiltonian of isolated monolayers,

$$H_0 = \mathbb{1}_M \otimes (-i\hbar v \, \boldsymbol{\sigma} \cdot \boldsymbol{\nabla}) \otimes \mathbb{1}_2^{(s)} \otimes \mathbb{1}_2^{(v)}, \tag{1}$$

consists of M copies of the familiar two-dimensional Dirac equation with the velocity $v \approx 10^6 \text{m/s}$ and the vector of Pauli matrices $\boldsymbol{\sigma} = (\sigma_x, \sigma_y)$. The notations $\mathbbm{1}_2^{(s)}$ and $\mathbbm{1}_2^{(v)}$ stand for the unit matrices in spin and valley space, respectively. The external magnetic field is described by the term $H_A = (ev/c)\,\boldsymbol{\sigma}\cdot\hat{\boldsymbol{A}}\otimes\mathbbm{1}_2^{(s)}\otimes\mathbbm{1}_2^{(v)}$, where $\hat{\boldsymbol{A}}(\boldsymbol{r}) = \text{diag}(\boldsymbol{A}_1, \boldsymbol{A}_2, \ldots, \boldsymbol{A}_M)$ with \boldsymbol{A}_m is the vector potential in the m-th layer. The weak crystal strain (e.g. induced by ripples) can be taken into account by a similar term $H_S = \boldsymbol{\sigma}\cdot\hat{\boldsymbol{S}}\otimes\mathbbm{1}_2^{(s)}\otimes\tau_z$ [25] with a strain field, $\boldsymbol{S}(\boldsymbol{r}) = \text{diag}(\boldsymbol{S}_1, \boldsymbol{S}_2, \ldots, \boldsymbol{S}_M)$, where τ_z stands for the Pauli matrix in the valley space. To simplify the notations we omit outer products and let $\hbar v = ev/c = 1$ in those expressions where it cannot cause confusion.

The interlayer coupling is described by taking into account the nearest-neighbour hopping both for intralayer and interlayer processes [26, 27],

$$H_{\perp} = \frac{t_{\perp}}{2} \begin{pmatrix} 0 & s_1 & 0 & 0 & \vdots \\ s_1^{\dagger} & 0 & s_2 & 0 & \vdots \\ 0 & s_2^{\dagger} & 0 & s_3 & \vdots \\ 0 & 0 & s_3^{\dagger} & 0 & \vdots \\ \dots & \dots & \dots & \dots \end{pmatrix}, \tag{2}$$

with $t_{\perp}=0.3$ -0.4 eV and $s_n=\sigma^{\pm}=\sigma_x\pm i\sigma_y$, where the choice of sign depends on the stacking order. The energetically most favourable configuration is the Bernal stacking (AB) characterised by $s_{2m}=\sigma_+, s_{2m+1}=\sigma_-$. The less favourable rhombohedral configuration (ABC) corresponds to $s_m=\sigma_+$ for $m=1,2,\ldots M-1$. The model is readily generalised to account for spatial variations of the hopping parameter.

The central property of our model is the chiral symmetry

$$\sigma_z H \sigma_z = -H,\tag{3}$$

which holds for any spatial dependence of the vector potential A, strain field S, and the hopping parameter t_{\perp} .

It follows from the chiral symmetry (3) that the spectrum determined by the "Dirac" equation, $H\Psi = \varepsilon \Psi$, is symmetric with respect to $\varepsilon = 0$. Analytical results are available for regular multilayers with $H_A = H_S = 0$. In

particular, the spectrum of the ABC-stacked multilayer is gapless and contains two branches touching at $\varepsilon = 0$ [27],

$$\varepsilon_{\mathbf{k}} = \pm t_{\perp} (|\mathbf{k}|\ell_{\perp})^{M} + t_{\perp} \mathcal{O} ((|\mathbf{k}|\ell_{\perp})^{M+1}), \qquad (4)$$

where $\ell_{\perp} \equiv \hbar v/t_{\perp} = 1.6\text{-}2.2\,\mathrm{nm}$ and k is the wave-vector. The spectrum of AB-stacked multilayer is given by [28]

$$\varepsilon_{m,\mathbf{k}} = t_{\perp} c_m \pm t_{\perp} \sqrt{|\mathbf{k}|^2 \ell_{\perp}^2 + c_m^2}, \quad c_m = \cos \frac{\pi m}{M+1}, \quad (5)$$

where m = 1, 2, ..., M. The result (5) is due to the exact mapping [26] onto a system of M/2 bilayers (for even M) or onto a system of a single monolayer and (M-1)/2 bilayers (for odd M).

For both models (4) and (5) the Fermi surface at $\varepsilon = 0$ becomes point-like. We shall see that this property extends to a general model with arbitrary spatially dependent terms H_A , H_S and H_{\perp} .

We define the matrix $\hat{\Omega}(\mathbf{r})$, which yields the equation $-\boldsymbol{\sigma} \nabla \hat{\Omega} = H_A + H_S + H_{\perp}$ and introduce the local gauge transformation [29]

$$\Psi(\mathbf{r}) = e^{i\hat{\Omega}(\mathbf{r})}\Phi(\mathbf{r}). \tag{6}$$

Using the chiral symmetry (3) one can show that the transformation (6) relates the zero-energy eigenstate, Ψ_0 , of the full Hamiltonian, $H\Psi_0 = 0$, to the eigenstate, Φ_0 , of the bare system, $H_0\Phi_0 = 0$. Since the spectrum of H_0 is gapless at $\varepsilon = 0$ and the Fermi surface is degenerate at $\varepsilon = 0$, the same properties apply to the full model, H.

In the following sections we explore the consequences for the transport properties of graphene multilayer.

Transfer matrix approach. — We apply the scattering approach to the transport in graphene multilayers for the two-terminal setup depicted in fig. 1 disregarding interaction effects. In particular, we calculate the full-counting statistics for the charge transport at zero frequency and temperature, which is determined by the cumulant generating function [30]

$$\mathcal{F}(\chi) = \ln \det \left[1 - \hat{t}\hat{t}^{\dagger} + e^{\chi} \hat{t}\hat{t}^{\dagger} \right], \tag{7}$$

where \hat{t} is the matrix of transmission amplitudes for the scattering states in the leads at a given energy ε . The conductance and the Fano factor are given by, respectively,

$$G = G_0 \lim_{\chi \to 0} \frac{\partial \mathcal{F}}{\partial \chi}, \quad F = (G_0/G) \lim_{\chi \to 0} \frac{\partial^2 \mathcal{F}}{\partial \chi^2},$$
 (8)

where $G_0 = 4e^2/h$ is the conductance quantum (the factor of 4 takes into account the spin and the valley degeneracy).

Following earlier works [16, 18, 19] we apply sharp boundary conditions at the metal-graphene interfaces at x = 0 and x = L. We also restrict ourselves to the limit $W \gg L$, where W is the width and L is the length of the rectangular graphene sample. Without loss of generality we apply periodic boundary conditions in y direction, (a

particular form of the boundary conditions is irrelevant for $W \gg L$), hence the momentum quantization in the leads, $q_n = 2\pi n/W$, where q stands for the projection of the momentum on q axis.

The transport properties are, then, characterised by the evolution matrix, \mathcal{T} , which relates the wave-function Fourier components in the left and the right lead $\Psi_q(L) = \sum_{q'} \mathcal{T}_{qq'} \Psi_{q'}(0)$. In the case of rigid boundary conditions the relation between the evolution matrix and the transfer matrix, \mathcal{M} , takes the simple form [19], $\mathcal{M} = \mathcal{L}^{\dagger} \mathcal{T} \mathcal{L}$ with $\mathcal{L} = (\sigma_z + \sigma_x)/\sqrt{2}$. Using the relation

$$\frac{\mathcal{M}\mathcal{M}^{\dagger}}{(1+\mathcal{M}\mathcal{M}^{\dagger})^{2}} = \frac{1}{4} \begin{pmatrix} \hat{t}\hat{t}^{\dagger} & 0\\ 0 & \hat{t}'^{\dagger}\hat{t}' \end{pmatrix}, \tag{9}$$

we rewrite the cumulant generating function (7) as

$$\mathcal{F} = \frac{1}{2} \ln \det \left[\left(1 - \mathcal{T} \mathcal{T}^{\dagger} \right)^{2} + 4 e^{\chi} \mathcal{T} \mathcal{T}^{\dagger} \right]. \tag{10}$$

In the next section we use this form of the generating function to analyse the transport properties of chiral graphene multilayers at $\varepsilon = 0$.

Transport at zero energy. – The transformation (6) enables us to calculate the charge transport at $\varepsilon=0$ for a general model. Let us start, however, from a simple case of ballistic multilayer in the absence of magnetic and strain fields, $H_A=H_S=0$. In this case, the gauge transformation (6) reduces to $\Psi=\mathrm{e}^{\mathrm{i}\hat{\Sigma}x}\Phi$ with $\hat{\Sigma}=-\sigma_xH_\perp$. Using this transformation we obtain the evolution matrix

$$\mathcal{T} = e^{qL\sigma_z} e^{i\hat{\Sigma}L}, \quad \mathcal{T}\mathcal{T}^{\dagger} = \begin{pmatrix} e^{2qL}\hat{P} & 0\\ 0 & e^{-2qL}\hat{P}^{-1} \end{pmatrix}, \quad (11)$$

with $\operatorname{diag}(\hat{P}, \hat{P}^{-1}) = \mathrm{e}^{\mathrm{i}\hat{\Sigma}L} \mathrm{e}^{-\mathrm{i}\hat{\Sigma}^{\dagger}L}$. We used that the matrices σ_z and $\hat{\Sigma}$ commute. The eigenvalues of the matrix \hat{P} are parameterised by $\exp(-2\kappa_m L)$. Since the eigenvalues coincide with those of \hat{P}^{-1} , they appear in pairs with $\kappa_{m,m'} = \pm |\kappa_m|$. (The unpaired eigenvalue for odd M corresponds to $\kappa_m = 0$.) From equations (11), (9) one finds individual transmission probabilities (which are the eigenvalues of $\hat{t}\hat{t}^{\dagger}$) as

$$T_m(q) = \left[\cosh^2(q - \kappa_m)L\right]^{-1}, \quad m = 1, 2, \dots M.$$
 (12)

The values of κ_m play the role of momentum shifts, which are irrelevant in the limit $W \gg L$, since the quantization of q is dense. In this limit the zero-energy generating function is obtained from equation (10) as

$$\mathcal{F}(\chi) = -M(W/\pi L) \left[\arccos(\exp \chi/2)\right]^2.$$
 (13)

This form of the generating function coincides with that of a diffusive system [31] despite the ballistic nature of charge transport in our model. The direct consequence of equation (13) is the universal form of the conductivity, G, and the Fano factor, F, at zero energy

$$G = 4e^2 MW/\pi hL, \qquad F = 1/3.$$
 (14)

The full-counting statistics (13) and the results (14) hold irrespective of the stacking order between the layers and are independent of the stacking specific momentum shifts κ_m . These results rely on the validity of the sharp boundary conditions with $\max \kappa_m \ll 2\pi/\lambda_F$, where λ_F stands for the Fermi wave length in the lead.

The momentum dependence of the transmission probabilities is less universal which is illustrated in fig. 2. For a multilayer with AB stacking we find

$$\kappa_m = L^{-1} \ln \left(c_m L / \ell_\perp + \sqrt{1 + c_m^2 (L / \ell_\perp)^2} \right),$$
(15)

where the coefficients c_m are defined in eq. (5) and m = 1, 2, ..., M. This result is consistent with the mapping of the multilayer onto independent bilayers [26]. For M = 2, the result of eq. (15) has been obtained by Snyman and Beenakker [18].

For the ABC stacking configuration we find the asymptotic expressions

$$\kappa_m = L^{-1} \ln \left(\frac{(M-m)!}{(m-1)!} (L/\ell_\perp)^{2m-M-1} \right),$$
(16)

in the limit $\ell_{\perp} \ll L$. The transmission resonances shown in fig. 2 are much better separated for the ABC multilayer than for the multilayer with the Bernal stacking. The momentum shifts κ_m in both cases depend logarithmically on the ratio L/ℓ_{\perp} , so that the condition $\max \kappa_m \ll 2\pi/\lambda_F$, is hard to violate. The validity of eq. (12) is restricted to $|\varepsilon| \ll \varepsilon_0$, where $\varepsilon_0 = t_{\perp}/(2c_1)(\pi\ell_{\perp}/L)^2$ for AB and $\varepsilon_0 \approx t_{\perp}(\pi\ell_{\perp}/L)^M$ for ABC stacking. For ballistic graphene ribbons with $W \lesssim L$, the full counting statistics is sensitive to the shifts κ_m due to the transversal momentum quantization.

Remarkably, the results (13,14) remain valid even in the presence of arbitrary magnetic and strain fields. To justify this statement it is convenient to consider the evolution operator \mathcal{T} in the real space representation, such that $\Psi(L,y) = \mathcal{T}\Psi(0,y)$. Using the transformation (6) we find

$$\mathcal{T} = e^{i\hat{\Omega}(L,y)} e^{-i\sigma_z L \partial_y} e^{-i\hat{\Omega}(0,y)}, \tag{17}$$

where the magnetic and strain fields and inter-layer coupling are entering solely by means of the matrix phase $\hat{\Omega}$ taken at the graphene-metal boundaries. The gauge of the vector potential can be chosen such that the phase at the boundary is y-independent. Hence the matrix exponents in eq. (17) commute and the evolution operator in the channel space takes the form of eq. (11) with $\Sigma = (\hat{\Omega}(L) - \hat{\Omega}(0))/L$.

that Dirac point, for $\varepsilon \ll \hbar v/L$, the transport is entirely due to the evanescent modes, which are responsible for the pseudo-diffusive form of the full counting statistics (13) at $\varepsilon = 0$. Away from the Dirac point, the transport is less universal and depends on a number of details. In this section we restrict ourselves to ballistic models with (14) $H_A = H_S = 0$.

We calculate the transmission probabilities $T_m(q)$ and perform the numerical integration over the transverse momentum q (assuming $2\pi/\lambda_F \gg |\varepsilon|$) to find the conductance and the Fano factor in the limit $W\gg L$. In the case of AB stacking the probabilities $T_m(q)$ can be found analytically and the resulting energy dependence of the conductance is shown in fig. 3 with dashed lines. The Fano factor for the trilayer with AB and ABC stacking is depicted with the dashed lines in fig. 4 (inset) and fig. 5, correspondingly. At $\varepsilon=0$ the figures confirm the results of eqs. (13,14).

For energies exceeding the ballistic Thouless energy, $\hbar v/L$, the transport is dominated by propagating modes, which give rise to the sample-specific Fabry-Pérot oscillations in conductance and noise. In order to get experimentally relevant results we perform the averaging over these oscillations treating the propagating phases as random quantities, which are uniformly distributed in the interval $(0, 2\pi)$ [32, 33]. This type of averaging corresponds to a quasiclassical approximation that respects the conservation of the transversal momentum, q, in the sample.

We introduce the individual scattering matrices for the left (L) and right (R) sample-lead interfaces

$$\hat{S}_{L/R} = \begin{pmatrix} \hat{\rho}_{L/R} & \hat{\tau}'_{L/R} \\ \hat{\tau}_{L/R} & \hat{\rho}'_{L/R} \end{pmatrix}, \tag{18}$$

which relate the scattering state amplitudes in the leads with those in the sample. We assume that the number of open channels in the sample equals $M_0 \leq M$ for a given energy, ε , and transversal momentum, q. In the planar geometry of fig. 1 the S-matrices in eq. (18) are readily calculated by matching the scattering states in the corresponding lead and in the sample.

As the result the total transmission matrix from the left to the right lead can be written as

$$\hat{t} = \hat{\tau}_{R} (1 - \hat{\tau}_{0} \hat{\rho}'_{L} \hat{\tau}_{0} \hat{\rho}_{R})^{-1} \hat{\tau}_{0} \hat{\tau}_{L},$$
 (19)

where $\hat{\tau}_0 = \mathrm{diag}(\mathrm{e}^{\mathrm{i}\phi_1},\ldots,\mathrm{e}^{\mathrm{i}\phi_{M_0}})$ is parameterised by the propagating phases $\phi_m = k_m L$ accumulated in the free propagation inside the sample. The number of propagating channels, M_0 , is determined from the requirement $\mathrm{Im}(k_m) = 0$, where the longitudinal momentum k_m is found from the dispersion relation $\varepsilon = \varepsilon(k,q)$ for a given energy ε and transversal momentum q.

An equivalent way to calculate the averaged conductance is formulated in terms of the classical transmission and reflection probabilities, $T_{R(L),nm} = |\tau_{R(L),nm}|^2$, and $R_{R(L),nm} = |\rho_{R(L),nm}|^2$, for the transport through the sample-graphene interfaces. The classical probabilities to pass through an entire sample are, then, organised in the following matrix $\hat{T} = \hat{T}_R(\mathbb{1} - \hat{R}'_L\hat{R}_R)^{-1}\hat{T}_L$, for each value of q. The quantity, \hat{T} , ignores the phase-coherence in the assumption that the transversal momentum is conserved inside the sample. The averaged conductance, $\overline{G} = G_0 \sum_q \sum_{nm} T_{nm}$ coincides with $\overline{G} = G_0 \sum_q \langle \operatorname{Tr} t \hat{t} t \rangle$,

where the brackets stay for the averaging over the propagating phases ϕ_m in Eq. (19).

A special case of a single propagating channel, $M_0 = 1$, per transversal momentum, q, is naturally realised in a monolayer and multilayers with a single ungapped band for energies below the lowest band threshold. The example of the latter is the ABC-stacked multilayer. For equivalent sample-lead junctions, the cumulant generating function (7) can be expressed using eq. (19) as

$$\mathcal{F}(\chi) = \sum_{q} \ln \frac{\bar{T}^2 e^{\chi} + 4(1 - \bar{T})\sin^2 \phi}{\bar{T}^2 + 4(1 - \bar{T})\sin^2 \phi}, \tag{20}$$

where $\bar{T} = \hat{\tau}\hat{\tau}^{\dagger}$ is the q-dependent transmission probability of the sample-lead interface. The averaging over the propagating phase, ϕ , can be performed analytically with the result

$$\overline{\mathcal{F}}(\chi) = 2\sum_{q} \ln \left[\overline{T} e^{\chi/2} + \sqrt{4(1-\overline{T}) + \overline{T}^2 e^{\chi}} \right]. \tag{21}$$

With the help of eq. (8) we obtain for the averaged conductance and the Fano factor

$$\overline{G} = G_0 \sum_{q} \frac{\overline{T}}{2 - \overline{T}}, \quad \overline{F} = \frac{G_0}{G} \sum_{q} \frac{2\overline{T}(1 - \overline{T})}{(2 - \overline{T})^3}.$$
 (22)

Let us digest eqs. (21,22) in the case of monolayer graphene. If the leads in the setup of fig. (1) are modelled by highly doped graphene one finds the interface transmission probability as $\overline{T}(q) = 1 - \tan^2 \theta/2$, where $q = |\varepsilon| \sin \theta$ and $\theta \in (-\pi/2, \pi/2)$ is the angle of incidence. For $W \gg L$ we replace the summation in eqs. (22) with the integration over q in the interval $(-\varepsilon, \varepsilon)$ and reproduce the asymptotic results [20] $\overline{G} = G_0 W |\varepsilon|/4$ and $\overline{F} = 1/8$.

Similarly, for the bilayer we find from eqs. (21,22) the averaged conductance below the band threshold,

$$\overline{G} = G_0 W \left(\frac{|\varepsilon|}{4} + t_\perp^2 \frac{\gamma - \eta}{8|\varepsilon|} \right), \quad |\varepsilon| < t_\perp, \quad (23)$$

where $\gamma = 1 + 2|\varepsilon|/t_{\perp}$ and $\eta = \sqrt{1 + \gamma - \gamma^{-1}}$. The result for the Fano factor in the bilayer setup takes the form

$$\overline{F} = \frac{G_0 W}{\overline{G}} \left(\frac{|\varepsilon|}{32} + t_\perp^4 \frac{4c_1 + c_2/(\gamma^3 \eta)}{512|\varepsilon|^3} \right), \quad |\varepsilon| < t_\perp, \quad (24)$$

where $c_1 = 3 - 7\gamma(1+\gamma) - \gamma^3$ and $c_2 = 3 + \gamma(\gamma+2)(16\gamma^4 + 12\gamma^3 - 17\gamma^2 + 10\gamma - 6)$.

If several propagating channels per the value of q open up in the sample, the averaging procedure is complicated and has to be carried out numerically. Still, for AB-stacked multilayers the analysis is simplified by using Koshino-Ando mapping [26] to an effective bilayer-monolayer system. For energies below the first band threshold, the conductance and noise can be constructed from the available analytical results for mono- and bi-layer graphene using the effective bilayer coupling constants,

 $t_{\perp,m}^{\rm eff}=2c_mt_{\perp}$, where $m=1,2,\ldots,{\rm Int}[M/2]$. For higher energies, one finds at most two propagating channels per q so that the numerical implementation of the averaging procedure is straightforward. The band thresholds are seen as kinks in the energy dependence (transmission spectra) of conductance and noise in figs. 3 and 4. At $\varepsilon=0$ we formally find $\overline{G}=0$ and (for AB-stacked multilayer) $\overline{F}=1/2$ for even M and $\overline{F}=(6M-5)/(12M-4)$ for odd number of layers, M. These results ignore the contribution of evanescent modes.

The interlayer coupling becomes irrelevant for the transport at energies far above all band thresholds. Universal asymptotic results, $G = MG_0W|\varepsilon|/4$ and F = 1/8, are obtained in this limit for any combination of AB and ABC stacking. This universality is due to the linear dispersion, $\varepsilon \approx c_m t_{\perp} \pm \hbar v |\mathbf{k}|$, of all spectral branches of our effective few-layer model at high energies.

One can modify the decomposition (19) to account for evanescent modes, which correspond to imaginary values of the propagating phases, $\phi_m = k_m L$, and use an appropriate analytic continuation of the matrices $\hat{S}_{\rm L/R}$, which become non-unitary. We employ this approach to plot the exact conductance and Fano factor for ABC-stacked graphene in fig. 5.

Conclusions. — A class of Hamiltonians describing few-layer graphene with spatially dependent strain and magnetic field obeys a chiral symmetry. This symmetry is responsible for the universal pseudo-diffusive charge transport via evanescent modes. The universality is understood on the basis of a non-Abelian gauge transformation at zero energy. For finite energies the full counting statistics of few-layer ballistic samples is calculated using the scattering approach.

* * *

We thank S. Gattenlöhner for valuable discussions. WRH acknowledges the financial support from the Scottish Universities Physics Alliance.

REFERENCES

- [1] Novoselov K. S., Geim A. K., Morozov S. V., Jiang D., Zhang Y., Dubonos S. V., Grigorieva I. V. and Firsov A. A., *Science*, **306** (2004) 666.
- [2] KANE C. L. and MELE E. J., Phys. Rev. Lett., 95 (2005) 146802; ibid., 95 (2005) 226801.
- [3] MOORE J. E. and BALENTS L., Phys. Rev. B, 75 (2007) 121306.
- [4] HSIEH D., QIAN D., WRAY L., XIA Y., HOR Y. S., CAVA
 R. J. and HASAN M. Z., Nature , 452 (2008) 970.
- [5] NOVOSELOV K. S., GEIM A. K., MOROZOV S. V., JIANG D., KATSNELSON M. I., GRIGORIEVA I. V., DUBONOS S. V. and FIRSOV A. A., Nature, 438 (2005) 197.
- [6] Zhang Y., Tan Y.-W., Stormer H. L. and Kim P., Nature, 438 (2005) 201.

- [7] NOVOSELOV K. S., McCann E., Morozov S. V., Fal'ko V. I., Katsnelson M. I., Zeitler U., Jiang D., Schedin F. and Geim A. K., *Nat. Phys.*, **2** (2006) 177.
- [8] RYCERZ A., TWORZYDLO J. and BEENAKKER C. W. J., Nat. Phys., 3 (2007) 172.
- [9] ABERGEL D. S. L. and CHAKRABORTY T., Appl. Phys. Lett., 95 (2009) 062107.
- [10] McCann E., Phys. Rev. B , 74 (2006) 161403.
- [11] SEMENOV Y. G., ZAVADA J. M. and KIM K. W., Phys. Rev. Lett., 101 (2008) 147206.
- [12] OOSTINGA J. B., HEERSCHE H. B., LIU X., MORPURGO A. F. and VANDERSYPEN L. M. K., Nat. Mater., 7 (2008) 151
- [13] HAN W., WANG W. H., PI K., MCCREARY K. M., BAO W., LI Y., MIAO F., LAU C. N. and KAWAKAMI R. K., Phys. Rev. Lett., 102 (2009) 137205.
- [14] MIN H., BISTRITZER R., SU J.-J. and MACDONALD A. H., Phys. Rev. B , 78 (2008) 121401.
- [15] KHARITONOV M. Y. and EFETOV K. B., Phys. Rev. B, 78 (2008) 241401.
- [16] TWORZYDLO J., TRAUZETTEL B., TITOV M., RYCERZ A. and BEENAKKER C. W. J., Phys. Rev. Lett., 96 (2006) 246802.
- [17] Katsnelson M. I., Eur. Phys. J. B, **51** (2006) 157.
- [18] SNYMAN I. and BEENAKKER C. W. J., Phys. Rev. B , 75 (2007) 045322.
- [19] Titov M., Europhys. Lett., **79** (2007) 17004.
- [20] SCHUESSLER A., OSTROVSKY P. M., GORNYI I. V. and MIRLIN A. D., Phys. Rev. B , 79 (2009) 075405.
- [21] TITOV M., OSTROVSKY P. M., GORNYI I. V., SCHUESSLER A. and MIRLIN A. D., arXiv:0908.3793 (2009).
- [22] TITOV M., OSTROVSKY P. M. and GORNYI I. V., Semicond. Sci. Technol., 25 (2010) 034007.
- [23] MIAO F., WIJERATNE S., ZHANG Y., COSKUN U. C., BAO W. and LAU C. N., Science, 317 (2007) 1530.
- [24] DANNEAU R., WU F., CRACIUN M. F., RUSSO S., TOMI M. Y., SALMILEHTO J., MORPURGO A. F. and HAKONEN P. J., Phys. Rev. Lett., 100 (2008) 196802.
- [25] PEREIRA V. M. and CASTRO NETO A. H., Phys. Rev. Lett., 103 (2009) 046801.
- [26] Koshino M. and Ando T., Phys. Rev. B , **76** (2007) 085425.
- [27] MIN H. and MACDONALD A. H., *Phys. Rev. B* , **77** (2008) 155416.
- [28] GUINEA F., NETO A. H. C. and PERES N. M. R., *Phys. Rev. B* , **73** (2006) 245426.
- [29] AHARONOV Y. and CASHER A., Phys. Rev. A , 19 (1979) 2461.
- [30] LEVITOV L. S. and LESOVIK G. B., JETP Lett., 58 (1993) 230.
- [31] DOROKHOV O. N., Pis ma Zh. Eksp. Teor. Fiz., 36 (1982) 259.
- [32] BÜTTIKER M., IBM J. Res. Dev., 32 (1988) 63.
- [33] Blanter Y. M. and Büttiker M., *Phys. Rep.* , **336** (2000) 1.